

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10591058	FUJII ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	BRIAN R SLAWSKI	1745

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
156	242, 243, 244.11, 244.18, 244.19, 244.23, 244.24, 244.25, 246, 248, 249, 250, 267, 269, 270, 271, 324, 500	04/2009, 11/2009, 08/2010, 03/2011	BRS
264	37.32, 146, 147, 171.1, 173.11, 173.14, 173.17, 173.18, 173.19, 210.1, 210.2, 211.12	04/2009, 11/2009, 08/2010, 03/2011	BRS
425	130, 131.1, 133.5, 461, 462, 463	04/2009, 11/2009, 08/2010, 03/2011	BRS

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	04/2009, 11/2009, 08/2010, 03/2011	BRS

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	USPat, PGPub, UPAD text search; see interference search printout	03/2011	BRS

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